

Notice of References Cited	Application/Control No. 09/585,460		Applicant(s)/Patent Under Reexamination STRIETZEL, JONATHAN	
	Examiner Quynh H. Nguyen		Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,603,844	08-2003	Chavez et al.	379/114.13
	B	US-			
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